TOSHIBA Intelligent Power Device Silicon Monolithic Power MOS Integrated Circuit

TPD1011S

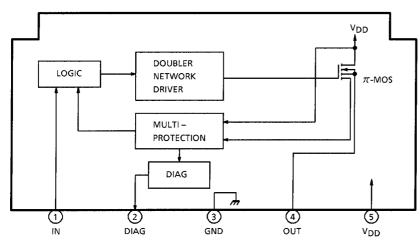
High-side Power Switch for Motors, Solenoids, and Lamp Drivers

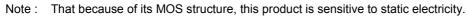
TPD1011S is a monolithic power IC for high-side switches. The IC has a vertical MOS FET output which can be directly driven from a CMOS or TTL logic circuit (eg, an MPU). The device offers intelligent self-protection and diagnostic functions.

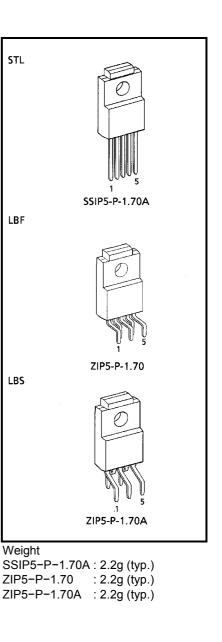
Features

- A monolithic power IC with a new structure combining a control block (Bi-CMOS) and a vertical power MOS FET (π–MOS) on a single chip.
- One side of load can be grounded to a high-side switch.
- Can directly drive a power load from a microprocessor.
- Built-in protection against thermal shutdown and load short circuiting. Also incorporates a diagnosis function that allows diagnosis output to be read externally at load short circuiting, opening, or overtemperature.
- Up to -10V of counterelectromotive force from an L load can be applied.
- Low on resistance $: R_{ON} = 60m\Omega \text{ (max)}$
- Low operating current : IDD = 1mA (typ.) (@VDD = 12V, VIN = 0V)
- 5-pin TO-220 insulated package.
- Three standard lead configurations.

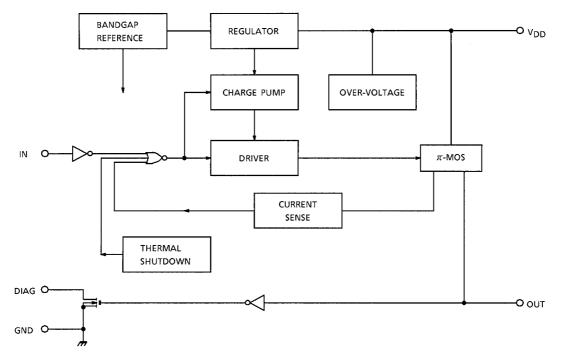
Pin Assignment







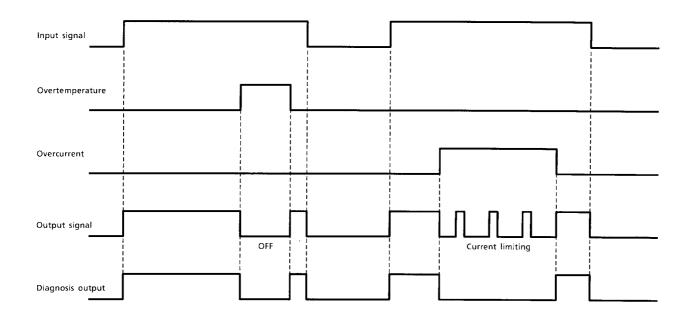
Block Diagram



Pin Description

Pin No.	Symbol	Function			
1	IN	Input pin. Input is CMOS-compatible, with pull-down resistor connected. Even if the input is open, output will not accidentally turn on.			
2	DIAG	Self-diagnosis detection pin. Goes low when overtemperature is detected or when output is short circuited with input on (high). n-channel open drain.			
3	GND	Ground pin.			
4	OUT	Output pin. When the load is short circuited and current in excess of the detection current flows to the output pin, the output automatically turns on or off.			
5	V _{DD}	Power pin.			

Timing Chart



Truth Table

Input Signal	Output Signal	Diagnosis Output	State	
Н	Н	Н	Normal	
L	L	L	Normai	
Н	L	L	Overcurrent	
L	L	L	Overcurrent	
Н	Н	Н	Load open	
L	Н	Н		
Н	L	L	Overtemperature	
L	L	L	Overtemperature	

Maximum Ratings (Ta = 25°C)

Characteris	tics	Symbol	Rating	Unit
Drain-source Voltage		V _{DS}	60	V
Supply Voltage	DC	V _{DD (1)}	25	V
Supply Voltage	Pulse	V _{DD (2)}	60 (Rs = 1Ω, τ = 250ms)	V
Input Voltage	DC	V _{IN (1)}	-0.5~12	V
input voltage	Pulse	V _{IN (2)}	V _{DD (1)} + 1.5 (t = 100ms)	V
Diagnosis Output Voltage		V _{DIAG}	-0.5~25	V
Output Current		Ι _Ο	Internally Limited	А
Input Current		I _{IN}	±10	mA
Diagnosis Output Current		I _{DIAG}	5	mA
Power Dissipation	Tc = 25°C	P _{D (1)}	30	W
	Ta = 25°C	P _{D (2)}	2	W
Operating Temperature		T _{opr}	-40~85	°C
Junction Temperature		Тj	150	°C
Storage Temperature		T _{stg}	-55~150	°C
Lead Temperature/time)	T _{SOL}	275 (5s), 260 (10s)	°C

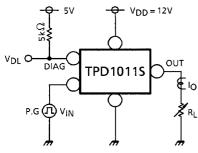
Electrical Characteristics (T_j = -40~85°C, V_{DD} = 8~18V)

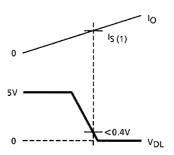
Characteri	Symbol	Test Circuit	Test Condition	Min	Тур.	Max	Unit	
Operating Supply Voltage		V _{DD (opr)}	_	—	5	12	18	V
Supply Current		I _{DD}		V _{DD} = 12V, V _{IN} = 0V		1	5	mA
Input Voltage		VIH		V _{DD} = 12V, I _O = 8A	3.5	_	_	V
		VIL	_	V _{DD} = 12V, I _O = 1.2mA	_	_	1.5	V
Input Current		I _{IN (1)}		V _{DD} = 12V, I _{IN} = 5V	_	50	200	μA
		I _{IN (2)}		V _{DD} = 12V, I _{IN} = 0V	-0.2	—	0.2	μA
On Voltage		V _{DS (ON)}	_	V _{DD} = 12V, I _O = 8A, T _j = 25°C	_	_	0.48	V
On Resistance		R _{DS (ON)}	_	V _{DD} = 12V, I _O = 8A, T _j = 25°C	_	—	0.06	Ω
Output Leakage Current		I _{OL}	_	V _{DD} = 18V, V _{IN} = 0V	_	_	1.2	mA
Diagnosis Output Voltage	"L" Level	V _{DL}	_	V _{DD} = 12V, I _{DL} = 1mA	_	_	0.4	V
Diagnosis Output Current	"H" Level	IDH	_	V _{DD} = 18V, V _{DH} = 18V	_	_	10	μA
Overcurrent Protection		I _{S (1)} (Note 1)	1	$1 = 40 \times T = 25^{\circ}0$	15	40	_	А
		I _{S (2)} (Note 2)	2	V _{DD} = 12V, T _j = 25°C	30	50	_	А
Thormal Chutdown	Temperature	T _S	_	_	150	160	200	°C
Thermal Shutdown	Hysteresis	ΔT _S		—		10	_	°C
Open Detection Resistance		R _{ops}		V _{DD} = 8V	1	50	100	kΩ
Switching Time		t _{ON}	3	V _{DD} = 12V, R _L = 5Ω T _j = 25°C	10	200	_	μs
		tOFF	3		10	30		μs

Note 1: I_{S (1)} Overcurrent detection value when load is short circuited and V_{IN} = "L" \rightarrow "H" Note 2: I_{S (2)} Overcurrent detection value when load current is increased while V_{IN} = "H"

Test Circuit 1

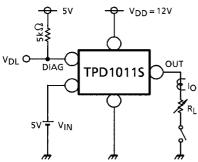
Overcurrent detection

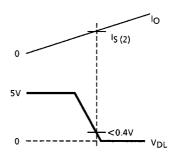




Test Circuit 2

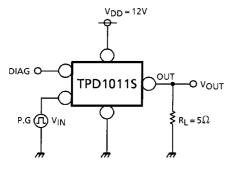
Over-current detection

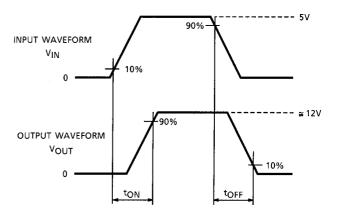


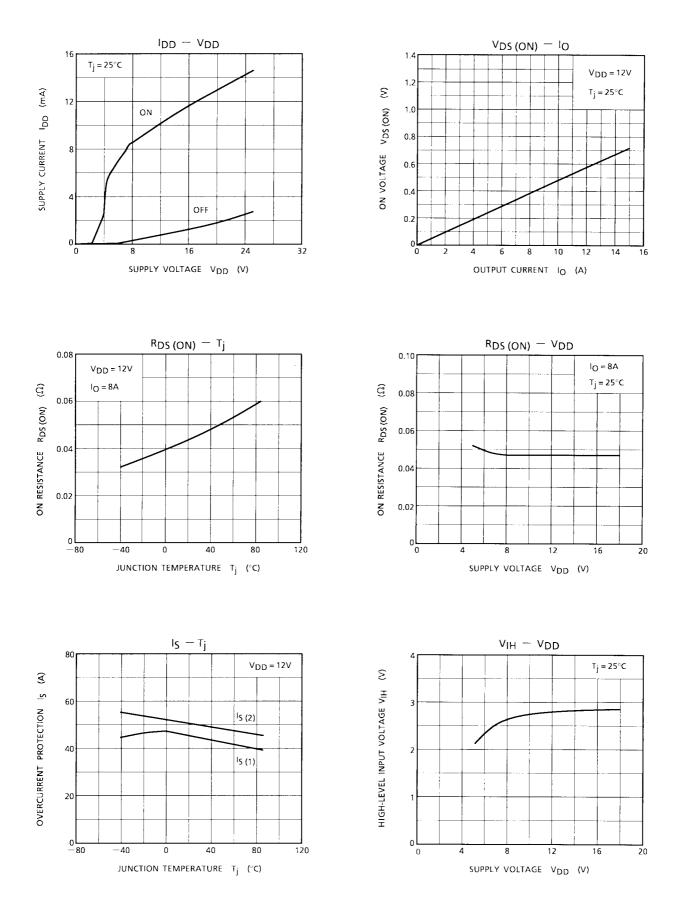


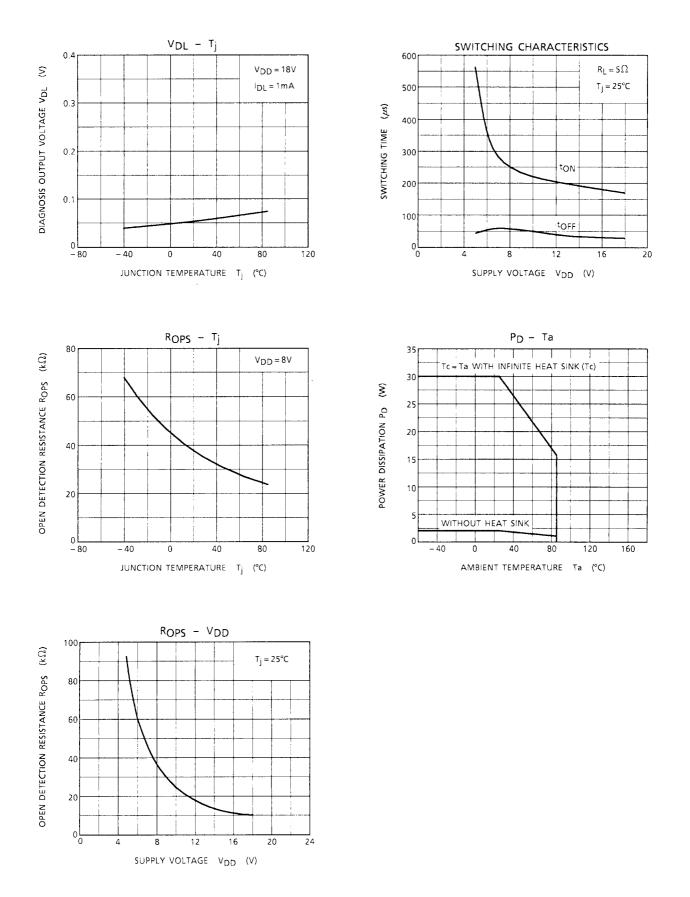
Test Circuit 3

Switching time







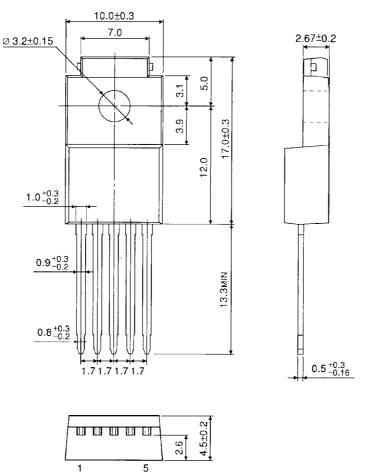


Precaution:

1. Since protection for, for example, reverse connection of the battery is not incorporated, provide protection using external circuits.

Package Dimensions

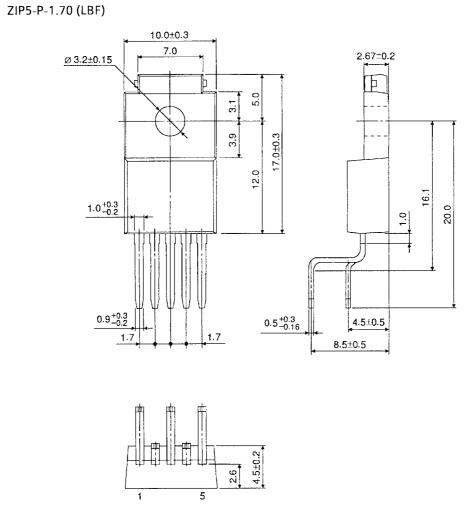
SSIP5-P-1.70A (STL)



Weight: 2.2g (typ.)

Unit : mm

Package Dimensions



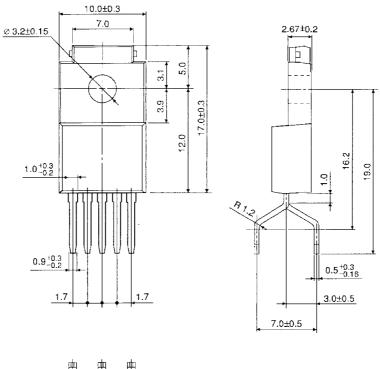
Weight: 2.2g (typ.)

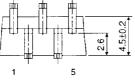
Unit : mm

Package Dimensions

ZIP5-P-1.70A (LBS)

Unit : mm





Weight: 2.2g (typ.)

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